SCBS001B - SEPTEMBER 1987 - REVISED NOVEMBER 1993

- State-of-the-Art BiCMOS Design Significantly Reduces I<sub>CCZ</sub>
- P-N-P Inputs Reduce DC Loading
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK) and Flatpacks (W), and Plastic and Ceramic 300-mil DIPs (J, N)

#### description

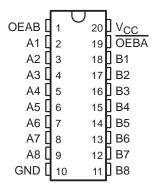
The 'BCT620A bus transceiver is designed for asynchronous communication between data buses. The control function implementation allows for maximum flexibility in timing. The 'BCT620A provides inverted data at its outputs.

These devices allow data transmission from the A bus to the B bus or from the B bus to the A bus depending upon the <u>logic</u> levels at the output-enable (OEAB and OEBA) inputs.

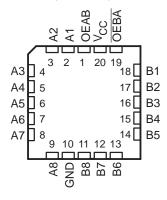
The output-enable inputs can be used to disable the device so that the buses are effectively isolated. The dual-enable configuration gives the transceivers the capability of storing data by simultaneously enabling OEAB and OEBA. When both OEAB and OEBA are enabled and all other data sources to the two sets of bus lines are at high impedance, both sets of bus lines (16 in all) will remain at their last states. In this way, each output reinforces its input in this configuration.

The SN54BCT620A is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to 125°C. The SN74BCT620A is characterized for operation from 0°C to 70°C.

#### SN54BCT620A . . . J OR W PACKAGE SN74BCT620A . . . DW OR N PACKAGE (TOP VIEW)



## SN54BCT620A . . . FK PACKAGE (TOP VIEW)



#### **FUNCTION TABLE**

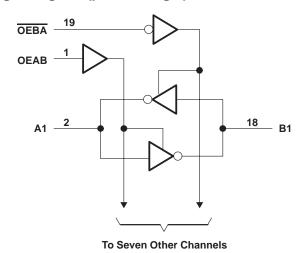
INP	UTS	ODED ATION					
OEBA	OEAB	OPERATION					
L	L	B data to A bus					
L	Н	B data to A bus, A data to B bus					
Н	L	Isolation					
Н	Н	A data to B bus					

SCBS001B - SEPTEMBER 1987 - REVISED NOVEMBER 1993

#### logic symbol†

#### **OEBA** OEAB EN2 18 В1 1 ⊲ 1⊳ 2♡ 17 B2 16 А3 15 Α4 14 **B5** 13 **B6 A6** 12 **B7** Α7 11 **A8 B8**

#### logic diagram (positive logic)



#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V <sub>CC</sub>		$\dots \dots -0.5 V$ to 7 V
Input voltage range: Control inputs (se	e Note 1)	$\dots \dots -0.5 V$ to 7 V
I/O ports (see Not	e 1)	– 0.5 V to 5.5 V
Voltage range applied to any output in	the disabled or power-off state, VO	– 0.5 V to 5.5 V
Voltage range applied to any output in	the high state, V <sub>O</sub>	– 0.5 V to V <sub>CC</sub>
Input clamp current, I <sub>IK</sub>		–30 mÅ
Current into any output in the low state	: SN54BCT620A	96 mA
	SN74BCT620A	128 mA
Operating free-air temperature range:	SN54BCT620A	– 55°C to 125°C
	SN74BCT620A	0°C to 70°C
Storage temperature range		– 65°C to 150°C

<sup>‡</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

#### recommended operating conditions

			SN54BCT620A			SN74BCT620A			UNIT
				NOM	MAX	MIN	NOM	MAX	UNIT
Vсс	Supply voltage			5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
$V_{IL}$	Low-level input voltage				0.8			0.8	V
Ι <sub>ΙΚ</sub>	Input clamp current				-18			-18	mA
IOH High-leve	High lovel output ourrent	A port			-3			-3	mA
	High-level output current	B port			-12			-15	IIIA
1	Loughered entered entered	A port			20			24	A
lOL	Low-level output current	B port			48			64	mA
T <sub>A</sub>	Operating free-air temperature		-55		125	0		70	°C



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

SCBS001B - SEPTEMBER 1987 - REVISED NOVEMBER 1993

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SNS	SN54BCT620A			SN74BCT620A		
				MIN	TYP†	MAX	MIN	TYP <sup>†</sup>	MAX	UNIT
VIK		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2		•	-1.2	V
	A port	V <sub>CC</sub> = 4.5 V	I <sub>OH</sub> = -1 mA	2.5	3.4		2.5	3.4		
			$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		V
Vон			$I_{OH} = -3 \text{ mA}$	2.4	3.3		2.4	3.3		
	B port	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2	3.2					
			$I_{OH} = -15 \text{ mA}$				2	3.1		
	A port	V <sub>CC</sub> = 4.5 V	$I_{OL} = 20 \text{ mA}$		0.3	0.5				V
VOL	Aport	VCC = 4.5 V	$I_{OL} = 24 \text{ mA}$					0.35	0.5	
VOL	B port	V <sub>CC</sub> = 4.5 V	$I_{OL} = 48 \text{ mA}$		0.38	0.55				
			$I_{OL} = 64 \text{ mA}$					0.42	0.55	
ļ	A or B port	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 5.5 V			1			1	m <sub>A</sub>
11	OEAB or OEBA		v j = 3.5 v			0.1			0.1	ША
I+	A or B port	V <sub>CC</sub> = 5.5 V,	$V_1 = 2.7 \text{ V}$			70			70	μΑ
¹IH <sup>‡</sup>	OEAB or OEBA	VCC = 3.5 V,				20			20	μΛ
I <sub>IL</sub> ‡	A or B port	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			-0.65			-0.65	mA
IIL*	OEAB or OEBA	VCC = 3.5 V,	V  = 0.5 V			-0.6			-0.6	ША
1 8	A port	V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 0	-60		-150	-60		-150	mA
los§	B port		00 = 0.5 v, v <sub>0</sub> = 0	-100		-225	-100		-225	ШД
ICCL	A to B	V <sub>CC</sub> = 5.5 V			53	84		53	84	mA
ICCH	A to B	V <sub>CC</sub> = 5.5 V			23	37		23	37	mA
ICCZ		V <sub>CC</sub> = 5.5 V			4	10		4	10	mA
Ci	OEAB or OEBA	$V_{CC} = 5 V$ ,	V <sub>I</sub> = 2.5 V or 0.5 V		5			5		pF
C	A to B	V <sub>CC</sub> = 5 V,	V <sub>O</sub> = 2.5 V or 0.5 V		9			9		n.E
C <sub>io</sub>	B to A		ν() = 2.5 ν UI U.5 ν		12			12		pF

<sup>†</sup> All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C. ‡ For I/O ports, the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current. § Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

SCBS001B - SEPTEMBER 1987 - REVISED NOVEMBER 1993

#### switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 5 V, $C_L$ = 50 pF, R1 = 500 Ω, R2 = 500 Ω, $T_A$ = 25°C			$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, R1 = 500 Ω, R2 = 500 Ω, $T_A$ = MIN to MAX $^\dagger$				UNIT	
			′BCT620A			SN54BC	T620A	SN74BCT620A			
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	1	
t <sub>PLH</sub>	А	В	0.6	3.4	5.2	0.6	6.2	0.6	5.8		
t <sub>PHL</sub>		В	0.1	1.9	3.4	0.1	3.7	0.1	3.6	ns	
t <sub>PLH</sub>	В	А	0.9	4.1	6	0.9	7.2	0.9	6.9	ns	
tPHL			0.1	2	3.7	0.1	4	0.1	3.9		
<sup>t</sup> PZH	<u>OEBA</u>	А	3.5	7.2	9.2	3.5	10.9	3.5	10.6	ns	
tpzL		A	3.7	7.6	9.9	3.7	11.5	3.7	11.1	115	
<sup>t</sup> PHZ	<del>OEBA</del>	А	3.1	5.3	8.6	3.1	10.8	3.1	10	ns	
tPLZ	OEBA	A	1.3	4.4	6.9	1.3	8.3	1.3	7.8	115	
<sup>t</sup> PZH	OEAB	OFAR	В	2	5.3	6.7	2	7.9	2	7.4	ns
t <sub>PZL</sub>		٥ ــــــــــــــــــــــــــــــــــــ	2.9	6.1	8.1	2.9	9.2	2.9	9	115	
t <sub>PHZ</sub>	OEAB	В	2.1	5.2	7	2.1	8.5	2.1	8.1	no	
t <sub>PLZ</sub>		OEAB		0.1	3.7	5.3	0.1	6	0.1	5.9	ns

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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